

20V N-Channel Trench MOSFET(Preliminary)

General Description

- Trench Power technology
- Low R_{DS(ON)}
- Low Gate Charge
- Optimized for fast-switching applications

Applications

- Synchronous Rectification in DC/DC and AC/DC Converters
- Isolated DC/DC Converters in Telecom and Industrial

Product Summary

 V_{DS} 20V I_{D} (at V_{GS} =10V) 120A

 $R_{DS(ON)}$ (at $V_{GS} = 10V$) < 3.4m Ω

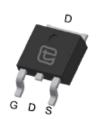
 $R_{DS(ON)}$ (at $V_{GS} = 4.5V$) < $3.8m\Omega$

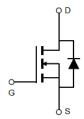
 $R_{DS(ON)}$ (at $V_{GS} = 2.5V$) < 5.1m Ω

100% UIS Tested



TO-252





Part Number	Package Type	Form	Marking
TTD120N02GT	TO-252	Tape&Reel	120N02GT

Absolute Maximum Ratings (T_A =25°C unless otherwise noted)

Parameter		Symbol	Maximum	Units	
Drain-Source Voltage		V _{DS}	20	V	
Gate-Source Voltage		V _{GS}	±20	V	
Continuous Drain Commant B	T _C =25°C		46	Δ.	
Continuous Drain Current B	T _C =100°C	I _D	46	А	
Pulsed Drain Current ^A		I _{DM}	360	А	
Avalanche Current ^A		I _{AS}	26	А	
Single Pulse Avalanche Energy L =0.3mH A		E _{AS}	101	mJ	
Power Dissipation ^C	T _C =25°C	D	108	W	
	T _C =100°C	P _D	54.3	W	
Junction and Storage Temperature Range		T _J , T _{STG}	-55 to 175	°C	

Thermal Characteristics

Parameter		Symbol	Maximum	Units
Maximum Junction-to-Case	Steady-State	R _{eJC} 1.38		00.444
Maximum Junction-to-Ambient	Steady-State	R _{eJA}	100	°C/W



Comple ed	B			Value			
Symbol	Parameter Conditions		Min	Тур	Max	Units	
STATIC P	ARAMETERS					_	
BV_{DSS}	Drain-Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0 V$		20			V
	7 0	$V_{DS} = 20V, V_{GS} = 0V$ $T_{J} = 25^{\circ}C$ $T_{J} = 100^{\circ}C$			1		
I _{DSS}	Zero Gate Voltage Drain Current		T _J =100°C			25	μA
I _{GSS}	Gate-Body Leakage Current	$V_{DS} = 0V, V_{GS} = \pm 20V$	•			±100	nA
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$		0.5	0.7	1.2	V
		V _{GS} =10V, I _D =30A			2.6	3.4	mΩ
R _{DS(ON)}	Static Drain-Source On-Resistance	V _{GS} =4.5V, I _D =30A			2.9	3.8	mΩ
		V _{GS} =2.5V, I _D =30A			3.9	5.1	mΩ
g _{FS}	Forward Transconductance	V _{DS} =10V, I _D =20A			15		S
V_{SD}	Diode Forward Voltage	I _S =46A, V _{GS} =0V				1	V
I _s	Maximum Body-Diode Continuous Current B				46	Α	
DYNAMIC	PARAMETERS				-		_
C _{iss}	Input Capacitance	V _{GS} =0V, V _{DS} =10V, f =1MH _Z			4066		
C _{oss}	Output Capacitance				1107		pF
C _{rss}	Reverse Transfer Capacitance				655		
SWITCHIN	NG PARAMETERS						
Q _g (10V)	Total Gate Charge	$V_{GS} = 10V, V_{DS} = 10V, I_{D} = 50A$			118		
Q_{gs}	Gate Source Charge				7		nC
Q_{gd}	Gate Drain Charge				22		
t _{D(on)}	Turn-On Delay Time	$V_{GS} = 10V, V_{DS} = 10V, I_{D} = 50A,$ $R_{G} = 3\Omega$			12		
t _r	Turn-On Rise Time				11		ns
$T_{D(off)}$	Turn-Off Delay Time				39		
t _f	Turn-Off Fall Time				18		
t _{rr}	Body Diode Reverse Recovery Time	I FOA d:/d+ 4004/			19		ns
Q _{rr}	Body Diode Reverse Recovery Charge	I _F =50A, di/dt =100A/μs			17		nC

- A. Single pulse width limited by maximum junction temperature.
- B. The maximum current rating is package limited.
- C. The power dissipation P_D is based on $T_{J(MAX)} = 175$ °C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

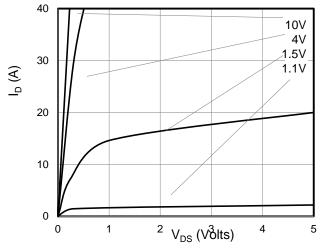


Figure 1: On-Region Characteristics

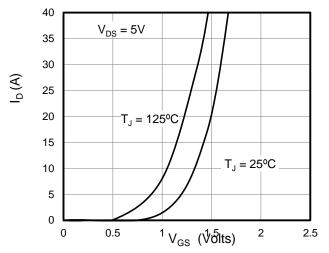


Figure 2: Transfer Characteristics

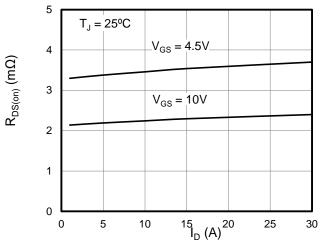


Figure 3: On-Resistance vs. Drain Current

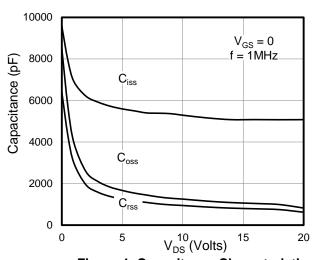


Figure 4: Capacitance Characteristics

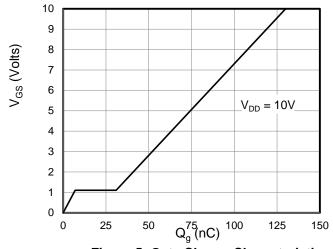


Figure 5: Gate Charge Characteristics

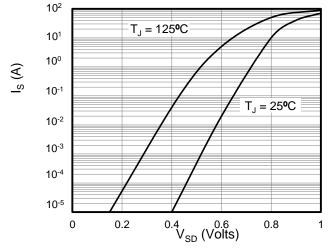


Figure 6: Body Diode Forward Voltage

 $Z_{\theta, JC}$ Normalized Transient Thermal Resistance

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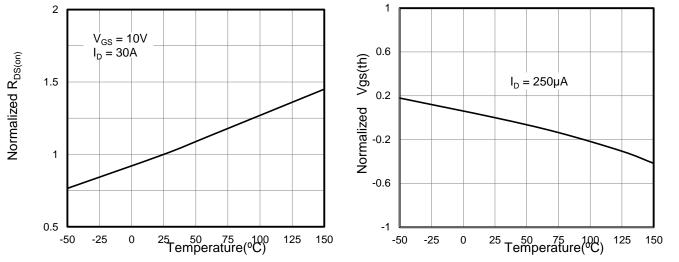


Figure 7: On-Resistance vs. Junction Temperature

Figure 8: Vgs(th) vs. Junction Temperature

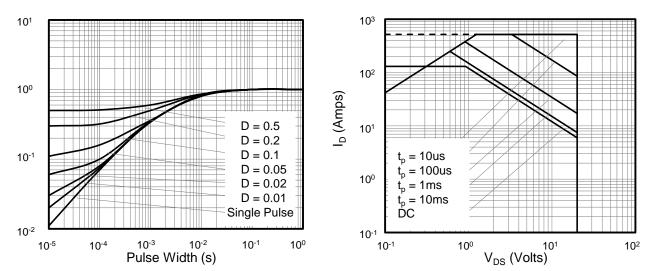


Figure 11: Normalized Transient Thermal Resistance

Figure 12: Safe Operating Area

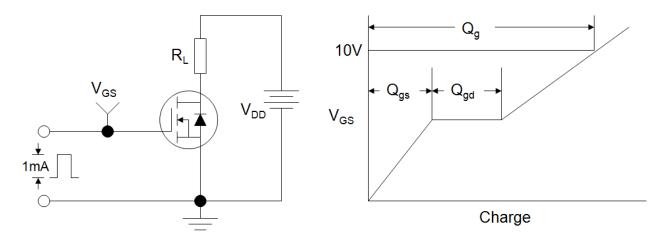


Figure A: Gate Charge Test Circuit and Waveforms

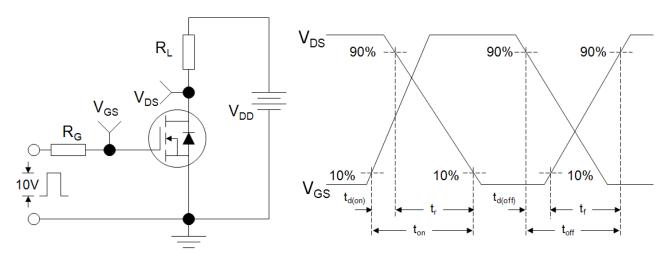


Figure B: Resistive Switching Test Circuit and Waveforms

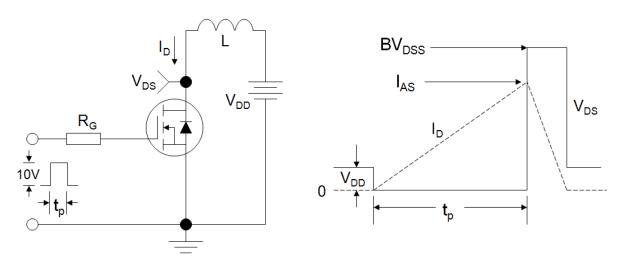
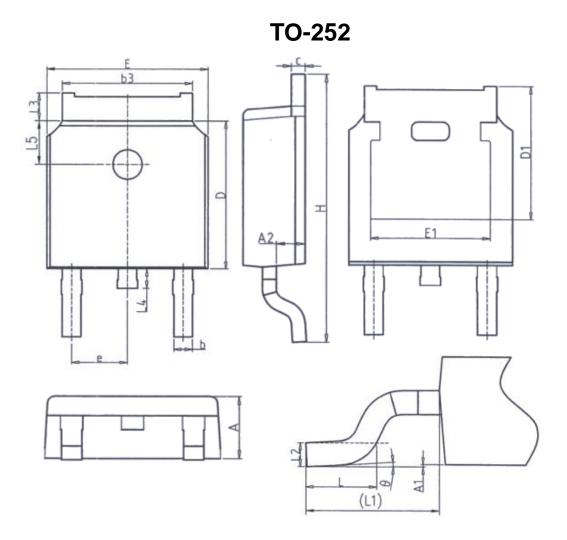


Figure C: Unclamped Inductive Switching (UIS) Test Circuit and Waveforms





Unit: mm			
Symbol	Min.	Max.	
Α	2. 20	2. 40	
A1	0.00	0. 20	
A2	0. 97	1. 17	
b	0. 68	0. 90	
b3	5. 20	5. 50	
С	0. 43	0. 63	
D	5. 98	6. 22	
D1	5. 30REF		
E	6. 40	6. 80	
E1	4. 63	_	

Unit: mm			
Symbol	Min.	Max.	
е	2. 286BSC		
Н	9. 40	10.50	
L	1. 38	1. 75	
L1	2. 90REF		
L2	0. 51BSC		
L3	0.88	1. 28	
L4	_	1.00	
L5	1. 65	1. 95	
θ	0°	8°	



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